


<b>Search Notes</b>  	<b>Application/Control No.</b>  10576042	<b>Applicant(s)/Patent Under Reexamination</b>  CAVANAGH ET AL.
	<b>Examiner</b>  JULIE HA	<b>Art Unit</b>  1654

SEARCHED			
Class	Subclass	Date	Examiner
None			

SEARCH NOTES		
Search Notes	Date	Examiner
EAST and PALM all inventor search	8/11/2008	JH
STIC: can be accessed via eDAN or SCORE	7/1/2008	JH
Interference search: US PG Pub and US Pat Full: (AIKLVQSP).clm.; ((AIKLVQSP) and tinea); ((AIKLVQSP) and fungus and tinea)	8/11/2008	JH
	8/11/2008	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
530	324, 325, 326, 327, 328	8/11/2008	JH
514	2, 12, 13, 14, 15, 16, 17	8/11/2008	JH

/J. H./  
Examiner, Art Unit 1654